

Search Notes

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Examiner

Michael J. Hayes

Applicant(s)/Patent under
Reexamination

BAUDINO ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(604/890.1-892.1,65-67,503-505,151) - see search history	4/15/2006	MJH